INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Multiple sheets used when necessary) SHEET 1 OF 2

	PTO/SB/08 Equivalen
Application No.	10/815,905
iling Date	March 31, 2004
irst Named Inventor	Lin et al.
Art Unit	2874
Examiner	Hoang Q. Tran
Attorney Docket No.	QCO.094A/061113

	U.S. PATENT DOCUMENTS				
Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
	1	4,863,245	9/5/1989	Roxlo	
	2	5,312,512	5/17/1994	Aliman et al.	
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	18	2002-0149850	10/17/2002	Heffner et al.	
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	25	2004-0100594	5/27/2004	Huibers et al.	

Date Considered

*Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Multiple sheets used when necessary) SHEET 2 OF 2

	PTO/SB/08 Equivalen
Application No.	10/815,905
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FOREIGN PATENT DOCUMENTS						
Examiner Initials	Cite No.	Foreign Patent Document Country Code-Number-Kind Code Example: JP 1234567 A1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear	T ¹
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NON PATENT LITERATURE DOCUMENTS			
Examiner Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ¹
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Examiner Signature

/Hoang Tran/ (01/20/2009)

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